

MAR 18 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No.: 10/604,102

Applicant(s): Steegan et al.

Filed.: June 26, 2003

Art Unit: 2815

Dkt. No.: FIS920030051US1

Examiner: Eckert II, George C.

Title: **SELECTIVE SILICON-ON-INSULATOR ISOLATION STRUCTURES AND
METHOD**

Honorable Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

REQUEST FOR RECONSIDERATION

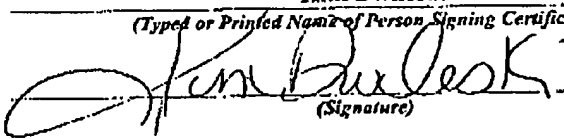
This Request for Reconsideration is being filed in response to the Office Action mailed
on February 28, 2005.

FIS920030055US1

FAX NO.

MAR 18 2005

P. 01

CERTIFICATE OF TRANSMISSION BY FACSIMILE (37 CFR 1.8)			Docket No. FIS920030051US1
Applicant(s): Steegan et al.			
Application No. 10/604,102	Filing Date 6/26/2003	Examiner Eckert II, George C.	Group Art Unit 2815
Invention: SELECTIVE SILICON-ON-INSULATOR ISOLATION STRUCTURES AND METHOD			
<p>I hereby certify that this <u>Request for Reconsideration (9 pages)</u> <small>(Identify type of correspondence)</small></p> <p>is being facsimile transmitted to the United States Patent and Trademark Office (Fax. No. <u>703-872-9306</u>)</p> <p>on <u>3/17/2005 3/18/05</u> <small>(Date)</small></p> <div style="text-align: right; margin-top: 100px;"> <p>Kim Dwileski <small>(Typed or Printed Name of Person Signing Certificate)</small></p>  <small>(Signature)</small> </div>			
<p>Note: Each paper must have its own certificate of mailing.</p>			